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SN65HVD1040A-Q1 EMC-Optimized High-Speed CAN Transceiver

1 Features

- Qualified for Automotive Applications
- • AEC-Q100 Test Guidance With the Following:
	- Device Temperature Grade 0: –40°C to +150°C Ambient Operating Temperature
	- Device HBM ESD Classification Level:
		- 3A Level for All Pins Except 5, 6, and 7
		- 3B Level for Pins 5, 6 and 7
	- Device CDM ESD Classification Level C6
	- Device MM ESD Classification Level M3
- Improved Drop-In Replacement for TJA1040
- Meets or Exceeds the Requirements of ISO 11898-5
- GIFT/ICT Compliant
- ESD Protection up to ±12 kV (Human-Body Model) on Bus Pins
- Low-Current Standby Mode With Bus Wake-Up, <12 μA Maximum
- High Electromagnetic Compliance (EMC)
- Bus-Fault Protection of –27 V to 40 V
- Dominant Time-Out Function
- **Thermal Shutdown Protection**
- SPLIT Voltage Source for Common-Mode Stabilization of Bus Through Split Termination
- • Digital Inputs Compatible With 3.3-V and 5-V Microprocessors.
- Power-Up and Power-Down Glitch-Free Bus Inputs and Outputs
- High Input Impedance With Low V_{CC}
- Monotonic Outputs During Power Cycling

2 Applications

- GMW3122 Dual-Wire CAN Physical Layers
- SAE J2284 High-Speed CAN for Automotive Applications
- SAE J1939 Standard Data Bus Interface
- ISO 11783 Standard Data Bus Interface
- NMEA 2000 Standard Data Bus Interface

3 Description

The SN65HVD1040A device meets or exceeds the specifications of the ISO 11898 standard for use in applications employing a Controller Area Network (CAN). The device is qualified for use in automotive applications.

As a CAN transceiver, this device provides differential transmit capability to the bus and differential receive capability to a CAN controller at signaling rates up to 1 megabit per second (Mbps) (1)

Device Information [\(a\)](#page-0-0)

(a) For all available packages, see the orderable addendum at the end of the data sheet.

(1) The signaling rate of a line is the number of voltage transitions that are made per second, expressed in the units bps (bits per second).

Functional Block Diagram

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Table of Contents

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

5 Description (continued)

Designed for operation in especially harsh environments, the SN65HVD1040A-Q1 features cross-wire, overvoltage, and loss of ground protection from –27 V to 40 V, overtemperature protection, a –12-V to 12-V common-mode range, and can withstand voltage transients according to ISO 7637.

STB (pin 8) provides two different modes of operation: high-speed mode or low-current standby mode. The highspeed mode of operation is selected by connecting STB (pin 8) to ground.

If a high logic level is applied to the STB pin of the SN65HVD1040A-Q1, the device enters a low-current standby mode, while the receiver remains active in a low-power bus-monitor standby mode.

In the low-current standby mode, a dominant bit greater than 5 μs on the bus is passed by the bus-monitor circuit to the receiver output. The local protocol controller may then reactivate the device when it needs to transmit to the bus.

A dominant time-out circuit in the SN65HVD1040A-Q1 prevents the driver from blocking network communication with a hardware or software failure. The time-out circuit is triggered by a falling edge on TXD (pin 1). If no rising edge is seen before the time-out constant of the circuit expires, the driver is disabled. The circuit is then reset by the next rising edge on TXD.

SPLIT (pin 5) is available as a $V_{CC}/2$ common-mode bus voltage bias for a split-termination network (see *Application and [Implementation](#page-18-0)*).

6 Pin Configuration and Functions

Pin Functions

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾⁽²⁾

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *[Recommended](#page-4-3) Operating [Conditions](#page-4-3)*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.

(3) Tested in accordance with ISO 7637 test pulses 1, 2, 3a, 3b per IBEE system level test (Pulse $1 = -100$ V, Pulse $2 = 100$ V, Pulse 3a = -150 V, Pulse 3b = 100 V). If dc may be coupled with AC transients, externally protect the bus pins within the absolute maximum voltage range at any bus terminal. This device has been tested with DC bus shorts to +40 V with leading common-mode chokes. If common-mode chokes are used in the system and the bus lines may be shorted to DC, ensure that the choke type and value in combination with the node termination and shorting voltage either does not create inductive flyback outside of voltage maximum specification or use an external transient-suppression circuit to protect the transceiver from the inductive transients.

7.2 ESD Ratings

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

(2) Test method based upon JEDEC Standard 22 Test Method A114F and AEC-Q100-002, CANH and CANL bus pins stressed with respect to each other and GND.

(3) Test method based upon JEDEC Standard 22 Test Method A114F and AEC-Q100-002, SPLIT pin stressed with respect to GND.

(4) Tested in accordance JEDEC Standard 22 Test Method A115A and AEC-Q100-003.

7.3 Recommended Operating Conditions

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7.4 Thermal Information

(1) For more information about traditional and new thermal metrics, see the application report, *[Semiconductor](http://www.ti.com/lit/pdf/spra953) and IC Package Thermal [Metrics](http://www.ti.com/lit/pdf/spra953)*.

(2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, Low-K board, as specified in JESD51-3, in an environment described in JESD51-2a.

(3) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, High-K board, as specified in JESD51-7, in an environment described in JESD51-2a.

7.5 Electrical Characteristics

over recommended operating conditions including operating free-air temperature range (unless otherwise noted)

(1) All typical values are at 25°C with a 5-V supply.

Electrical Characteristics (continued)

over recommended operating conditions including operating free-air temperature range (unless otherwise noted)

7.6 Power Dissipation Characteristics

over recommended operating conditions, $T_A = -40^{\circ}C$ to 125°C (unless otherwise noted)

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Power Dissipation Characteristics (continued)

over recommended operating conditions, $T_A = -40^{\circ}C$ to 125°C (unless otherwise noted)

7.7 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

(1) The TXD dominant time-out $(t_{(dom)})$ disables the driver of the transceiver once the TXD has been dominant longer than $t_{(dom)}$, which releases the bus lines to recessive, preventing a local failure from locking the bus dominant. The driver may only transmit dominant again after TXD has been returned HIGH (recessive). While this protects the bus from local faults, locking the bus dominant, it limits the minimum data rate possible. The CAN protocol allows a maximum of eleven successive dominant bits (on TXD) for the worst case, where 5 successive dominant bits are followed immediately by an error frame. This, along with the $t_{(dom)}$ minimum, limits the minimum bit rate. The minimum bit rate may be calculated by:

Minimum Bit Rate = 11/ $t_{(dom)} = 11$ bits / 300 μ s = 37 kbps

8

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7.8 Typical Characteristics

8 Parameter Measurement Information

Figure 4. Driver V_{OD} Test Circuit

Figure 5. Driver Test Circuit and Voltage Waveforms

Figure 6. Receiver Voltage and Current Definitions

Parameter Measurement Information (continued)

- A. The input pulse is supplied by a generator having the following characteristics: PRR ≤ 125 kHz, 50% duty cycle, $t_r \le 6$ ns, $t_f \le 6$ ns, $Z_O = 50$ Ω .
- B. C_L includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 7. Receiver Test Circuit and Voltage Waveforms

Table 1. Differential Input Voltage Threshold Test

- B. All V_I input pulses are supplied by a generator having the following characteristics: t_r or t_f ≤ 6 ns,
	- pulse repetition rate (PRR) = 125 kHz, 50% duty cycle.

Figure 8. ten Test Circuit and Waveforms

VCC

0 V

VOH

VOL

NOTE: All V_I input pulses are from 0 V to V_{CC} and supplied by a generator having the following characteristics: t_r or t_f ≤ 6 ns, pulse repetition rate (PRR) = 125 kHz, 50% duty cycle.

Figure 9. Common-Mode Output Voltage Test and Waveforms

- A. $C_L = 100$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.
- B. All V_I input pulses are from 0 V to V_{CC} and supplied by a generator having the following characteristics: t_r or t_f ≤ 6 ns, pulse repetition rate (PRR) = 125 kHz, 50% duty cycle.

Figure 10. t(LOOP) Test Circuit and Waveforms

- A. $\;$ All V_I input pulses are from 0 V to V_{CC} and supplied by a generator having the following characteristics: t_r or t_f ≤ 6 ns, pulse repetition rate (PRR) = 500 Hz, 50% duty cycle.
- B. $C_L = 100$ pF includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 11. Dominant Time-Out Test Circuit and Waveforms

- A. For V_I bit width ≤ 0.7 µs, V_O = V_{OH}. For V_I bit width ≥ 5 µs, V_O = V_{OL}. V_I input pulses are supplied from a generator with the following characteristics: $t_r/t_f < 6$ ns.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 13. t_{BUS} Test Circuit and Waveforms

A. All V_I input pulses are from 0 V to V_{CC} and supplied by a generator having the following characteristics: t_r/t_f ≤ 6 ns, pulse repetition rate (PRR) = 250 kHz, 50% duty cycle.

Figure 14. Driver Output Symmetry Test Circuit

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9 Detailed Description

9.1 Overview

The SN65HVD1040A-Q1 CAN tranceiver is compatible with the ISO 11898-2 high-speed CAN (Controller Area Network) physical layer standard. The device is designed to interface between the differential bus lines in controller area network and the CAN protocol controller at data rates up to 1 Mbps.

9.2 Functional Block Diagram

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9.3 Feature Description

9.3.1 Operating Modes

The device has two main operating modes: normal mode and standby mode. Operating mode selection is made through the STB input pin.

Table 2. Operating Modes

9.3.1.1 Bus States by Mode

The CAN bus has three valid states during powered operation depending on the mode of the device. In normal mode the bus may be dominant (logic low) where the bus lines are driven differentially apart or recessive (logic high) where the bus lines are biased to $V_{\rm CC}/2$ through the high-ohmic internal input resistors $R_{\rm IN}$ of the receiver. The third state is low-power standby mode where the bus lines are biased to GND through the high-ohmic internal input resistors R_{IN} of the receiver.

Figure 15. Bus States (Physical Bit Representation) Figure 16. Simplified Common-Mode Bias and

RXD

9.3.1.2 Normal Mode

This is the normal operating mode of the device. It is selected by setting STB low. The CAN driver and receiver are fully operational and CAN communication is bidirectional. The driver is translating a digital input on TXD to a differential output on CANH and CANL. The receiver is translating the differential signal from CANH and CANL to a digital output on RXD. In recessive state the bus pins are biased to 0.5 \times V_{CC}. In dominant state the bus pins (CANH and CANL) are driven differentially apart. Logic high is equivalent to recessive on the bus and logic low is equivalent to a dominant (differential) signal on the bus.

The SPLIT pin is biased to 0.5 \times V_{CC} for bus common-mode bus voltage bias stabilization in split termination network applications (see *Application and [Implementation](#page-18-0)*).

9.3.1.3 Standby Mode and RXD Wake-Up Request

This is the low-power mode of the device. It is selected by setting STB high. The CAN driver and main receiver are turned off and bidirectional CAN communication is not possible. The low-power receiver and bus monitor are enabled to allow for wake-up requests through the bus. A wake-up request will be output to RXD (driven low) for any dominant bus transmissions longer than the filter time t_{BUS} . The local protocol controller (MCU) should monitor RXD for transitions and then reactivate the device to normal mode based on the wake-up request. The CAN bus pins are weakly pulled to GND and the SPLIT pin is off (floating).

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ISTRUMENTS

9.3.2 Protection Features

9.3.2.1 TXD Dominant State Time-Out

During normal mode (the only mode in which the CAN driver is active) the TXD dominant time-out circuit prevents the transceiver from blocking network communication in event of a hardware or software failure where TXD is held dominant longer than the time-out period t_{DST} . The dominant time-out circuit is triggered by a falling edge on TXD. If no rising edge is seen before the time-out constant of the circuit expires (t_{DST}), the CAN bus driver is disabled, thus freeing the bus for communication between other network nodes. The CAN driver is reactivated when a recessive signal is seen on the TXD pin, thus clearing the dominant state time-out. The CAN bus pins are biased to recessive level during a TXD dominant state time-out and SPLIT remains on.

NOTE

The maximum dominant TXD time allowed by the TXD Dominant state time-out limits the minimum possible data rate of the device. The CAN protocol allows a maximum of 11 successive dominant bits (on TXD) for the worst case, where 5 successive dominant bits are followed immediately by an error frame. This, along with the $t_{(dom)}$ minimum, limits the minimum bit rate. The minimum bit rate may be calculated by: Minimum Bit Rate $=$ $11/t_{(dom)}$

9.3.2.2 Thermal Shutdown

If the junction temperature of the device exceeds the thermal shutdown threshold the device turns off the CAN driver circuits, including the SPLIT pin. This condition is cleared when the temperature drops below the thermal shutdown temperature of the device.

9.3.2.3 Undervoltage Lockout and Unpowered Device

The device has undervoltage detection and lockout on the V_{CC} supply. If an undervoltage condition is detected on V_{CC} , the device protects the bus.

The TXD pin is pulled up to V_{CC} to force a recessive input level if the pin floats. The STB is pulled up to V_{CC} to force the device in standby mode (low power) if the pin floats.

The bus pins (CANH, CANL, and SPLIT) all have extremely low leakage currents when the device is unpowered so it does not load down the bus but be an *ideal passive* load to the bus. This is critical, especially if some nodes of the network are unpowered while the rest of the network remains in operation.

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9.4 Device Functional Modes

[Table](#page-16-2) 3 and [Table](#page-16-3) 4 lists the functions of this device.

Table 3. Driver Function Table(1)

(1) H = high level, L = low level, X = irrelevant, Y = weak pulldown to GND, ? = indeterminate, Z = high impedance

Table 4. Receiver Function Table

Figure 18. Equivalent Input and Output Schematic Diagrams

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10 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

10.1.1 Using With 3.3-V Microcontrollers

The input level threshold for the digital input pins of this device are 3.3-V compatible; however, a few application considerations must be taken if using this device with 3.3-V microcontrollers. Both TXD and STB input pins have internal pullup sources to V_{CC} . Some microcontroller vendors recommend using an open-drain configuration on their I/O pins in this case even though the pullup limits the current. Take care of the application level so that TXD and STB have sufficient pullup to meet system timing requirements for CAN. The internal pullup on TXD especially may not be sufficient to overcome the parasitic capacitances and allow for adequate CAN timing; thus, an additional external pullup may be required. Also take care of the RXD pin of the microcontroller as the RXD output of this device drives the full V_{CC} range (5 V). If the microcontroller RXD input pin is not 5-V tolerant, this must be addressed at the application level. Other options include using a CAN transceiver from TI with I/O level adapting or a 3.3-V CAN transceiver.

10.1.2 Using SPLIT With Split Termination

The SPLIT pin voltage output provides 0.5 \times V_{CC} in normal mode. The circuit may be used by the application to stabilized the common-mode voltage of the bus by connecting it to the center tap of split termination for the CAN network (see [Figure](#page-18-2) 19 and [Figure](#page-19-1) 20). This pin provides a stabilizing recessive voltage drive to offset leakage currents of unpowered transceivers or other bias imbalances that might bring the network common-mode voltage away from 0.5 \times V_{CC}. Using this feature in a CAN network improves electromagnetic emissions behavior of the network by eliminating fluctuations in the bus common-mode voltage levels at the start of message transmissions.

Figure 19. Split Pin Stabilization Circuitry and Application

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10.2 Typical Application

Figure 20. Typical Application Using Split Termination for Stabilization Diagram

10.2.1 Design Requirements

10.2.1.1 Bus Loading, Length, and Number of Nodes

The ISO 11898 Standard specifies up to 1-Mbps data rate, maximum bus length of 40 meters, maximum drop line (stub) length of 0.3 meters, and a maximum of 30 nodes. However, with careful network design, the system may have longer cables, longer stub lengths, and many more nodes to a bus. Many CAN organizations and standards have scaled the use of CAN for applications outside the original ISO 11898 standard. They have made system-level trade-offs for data rate, cable length, and parasitic loading of the bus. Examples of some of these specifications are ARINC825, CANopen, CAN Kingdom, DeviceNet, and NMEA200.

Figure 21. Typical CAN Bus Drawing

Typical Application (continued)

A high number of nodes requires a transceiver with high input impedance and wide common-mode range such as the SN65HVD1040A-Q1 CAN transceiver. ISO 11898-2 specifies the driver differential output with a 60-Ω load (two 120-Ω termination resistors in parallel) and the differential output must be greater than 1.5 V. The SN65HVD1040A-Q1 device is specified to meet the 1.5-V requirement with a 60-Ω load, and additionally specified with a differential output voltage minimum of 1.2 V across a common-mode range of -2 V to 7 V through a 330-Ω coupling network. This network represents the bus loading of 90 SN65HVD1040A-Q1 transceivers based on their minimum differential input resistance of 30 kΩ. Therefore, the SN65HVD1040A-Q1 supports up to 90 transceivers on a single bus segment with margin to the 1.2-V minimum differential input voltage requirement at each node.

For CAN network design, margin must be given for signal loss across the system and cabling, parasitic loadings, network imbalances, ground offsets, and signal integrity, thus a practical maximum number of nodes may be lower. Bus length may also be extended beyond the original ISO 11898 standard of 40 meters by careful system design and data rate tradeoffs. For example, CANopen network design guidelines allow the network to be up to 1-km with changes in the termination resistance, cabling, less than 64 nodes and significantly lowered data rate.

This flexibility in CAN network design is one of the key strengths of the various extensions and additional standards that have been built on the original ISO 11898 CAN standard.

10.2.1.2 CAN Termination

The ISO 11898 standard specifies the interconnect to be a twisted pair cable (shielded or unshielded) with 120- Ω characteristic impedance (Z_O) . Resistors equal to the characteristic impedance of the line must be used to terminate both ends of the cable to prevent signal reflections. Unterminated drop lines (stubs) connecting nodes to the bus must be kept as short as possible to minimize signal reflections. The termination may be on the cable or in a node, but if nodes may be removed from the bus the termination must be carefully placed so that it is not removed from the bus.

Termination is typically a 120- Ω resistor at each end of the bus. If filtering and stabilization of the common-mode voltage of the bus is desired, then split termination may be used (see [Figure](#page-20-0) 22 and *Using [SPLIT](#page-18-3) With Split [Termination](#page-18-3)*).

Take care when determining the power ratings of the termination resistors. A typical worst-case fault condition is if the system power supply and ground were shorted across the termination resistance which would result in much higher current through the termination resistance than the current limit of the CAN transceiver.

10.2.1.3 Loop Propagation Delay

Transceiver loop delay is a measure of the overall device propagation delay, consisting of the delay from the driver input (the TXD pin) to the differential outputs (the CANH and CANL pins), plus the delay from the receiver inputs (the CANH and CANL) to its output (the RXD pin). A typical loop delay for the SN65HVD1040A-Q1 transceiver is displayed in [Figure](#page-21-0) 24 and [Figure](#page-21-0) 25.

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Typical Application (continued)

10.2.2 Detailed Design Procedure

10.2.2.1 Transient Voltage Suppresser (TVS) Diodes

Transient voltage suppressors are the preferred protection components for a CAN bus due to their low capacitance, which allows them to be designed into every node of a multinode network without requiring a reduction in data rate. With response times of a few picoseconds and power ratings of up to several kilowatts, TVS diodes present the most effective protection against ESD, burst, and surge transients.

Figure 23. Transient Voltage Suppresser (TVS) Diodes Schematic

11 Power Supply Recommendations

To ensure reliable operation at all data rates and supply voltages, each supply must be decoupled with a 100-nF ceramic capacitor located as close as possible to the V_{CC} supply pins as possible. The TPS76350 device is a linear voltage regulator suitable for the 5-V supply rail.

12 Layout

12.1 Layout Guidelines

For the PCB design to be successful, start with design of the protection and filtering circuitry. Because ESD and EFT transients have a wide frequency bandwidth from approximately 3-MHz to 3-GHz, high-frequency layout techniques must be applied during PCB design. On-chip IEC ESD protection is good for laboratory and portable equipment but is usually not sufficient for EFT and surge transients occurring in industrial environments. Therefore, robust and reliable bus node design requires the use of external transient protection devices at the bus connectors. Placement at the connector also prevents these harsh transient events from propagating further into the PCB and system.

Use V_{CC} and ground planes to provide low inductance.

NOTE

High-frequency current follows the path of least inductance and not the path of least resistance.

Design the bus protection components in the direction of the signal path. Do not force the transient current to divert from the signal path to reach the protection device. An example placement of the Transient Voltage Suppression (TVS) device indicated as D1 (either bidirectional diode or varistor solution) and bus filter capacitors C5 and C7 are shown in [Figure](#page-23-2) 26.

The bus transient protection and filtering components must be placed as close to the bus connector, J1, as possible. This prevents transients, ESD and noise from penetrating onto the board and disturbing other devices.

Bus termination: [Figure](#page-20-0) 22 shows split termination. This is where the termination is split into two resistors, R5 and R6, with the center or split tap of the termination connected to ground through capacitor C6. Split termination provides common-mode filtering for the bus. When termination is placed on the board instead of directly on the bus, take care to ensure the terminating node is not removed from the bus as this causes signal integrity issues if the bus is not properly terminated on both ends.

Bypass and bulk capacitors should be placed as close as possible to the supply pins of transceiver, examples include C2 and C3 (V_{CC}).

Use at least two vias for V_{CC} and ground connections of bypass capacitors and protection devices to minimize trace and via inductance.

To limit current of digital lines, serial resistors may be used. Examples are R1, R2, R3, and R4.

To filter noise on the digital IO lines, a capacitor may be used close to the input side of the IO as shown by C1 and C4.

Because the internal pullup and pulldown biasing of the device is weak for floating pins, an external 1-kΩ to 10 kΩ pullup or pulldown resistor must be used to bias the state of the pin more strongly against noise during transient events.

Pin 1: If an open-drain host processor is used to drive the TXD pin of the device an external pullup resistor between 1 kΩ and 10 kΩ must be used to drive the recessive input state of the device.

Pin 5: SPLIT must be connected to the center point of a split termination scheme to help stabilize the commonmode voltage to V_{CC} /2. If SPLIT is unused it must be left floating.

Pin 8: Is shown assuming the mode pin, STB, is used. If the device is only used in normal mode, R3 is not needed and the pads of C4 could be used for the pulldown resistor to GND.

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12.2 Layout Example

Figure 26. Typical CAN Bus Layout Example

12.3 ESD Protection

A typical application that employees a CAN bus network may require some form of ESD, burst, and surge protection to shield the CAN transceiver against unwanted transients that can potential damage the transceiver. To help shield the SN65HVD1040A-Q1 transceiver against these high-energy transients, transient voltage suppressors can be implemented on the CAN differential bus terminals. These devices help absorb the impact of a ESD, burst, or surge strike.

13 Device and Documentation Support

13.1 Receiving Notification of Documentation Updates

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13.3 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

13.4 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

13.5 Glossary

[SLYZ022](http://www.ti.com/lit/pdf/SLYZ022) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 6-Feb-2020

PACKAGING INFORMATION

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures. "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the ≤ 1000 ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

Texas
Instruments

TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

TEXAS
INSTRUMENTS

www.ti.com 3-Feb-2016

PACKAGE MATERIALS INFORMATION

*All dimensions are nominal

PACKAGE OUTLINE

D0008A SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.

- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.

EXAMPLE BOARD LAYOUT

D0008A SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.

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